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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10813212 | <b>Applicant(s)/Patent Under Reexamination</b><br>QUMEI, IYAD |
|  | <b>Examiner</b><br>Chen, Shin-Hon          | <b>Art Unit</b><br>2131                                       |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |         |          |
|---|---------|----------|
| Search Notes  | Date    | Examiner |
| USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history) | 6/13/07 | S.C.     |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |